

Notice of References Cited

Application/Control No.

10/691,290

Applicant(s)/Patent Under
Reexamination
FREI ET AL.

Examiner

Nicholas Augustine

Art Unit

2179

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,307,055 A	04-1994	Baskin et al.	345/2.2
*	B	US-5,305,435 A	04-1994	Bronson, Barry	715/777
*	C	US-5,307,086 A	04-1994	Griffin et al.	715/808
*	D	US-5,394,521 A	02-1995	Henderson et al.	715/804
*	E	US-5,412,776 A	05-1995	Bloomfield et al.	715/783
*	F	US-5,640,522 A	06-1997	Warrin, Paul	715/732
*	G	US-5,734,380 A	03-1998	Adams et al.	715/804
*	H	US-5,790,820 A	08-1998	Vayda et al.	715/834
*	I	US-5,959,627 A	09-1999	Duwaer et al.	715/797
*	J	US-5,990,931 A	11-1999	Nimri et al.	348/14.08
*	K	US-5,995,103 A	11-1999	Ashe, Dylan B.	715/804
*	L	US-6,069,625 A	05-2000	Nielsen, Jakob	715/866
*	M	US-6,075,531 A	06-2000	DeStefano, George Francis	715/788

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,104,395 A	08-2000	Alimpich et al.	715/781
*	B	US-6,097,389 A	08-2000	Morris et al.	715/804
*	C	US-6,191,758 B1	02-2001	Lee, Sang-jin	345/2.2
*	D	US-6,222,542 B1	04-2001	Poreh et al.	715/804
*	E	US-6,396,514 B1	05-2002	Kohno, Akihiro	715/753
*	F	US-2002/0080380 A1	06-2002	Sugiura et al.	358/1.13
*	G	US-2002/0089518 A1	07-2002	Shigeta, Kazuyuki	345/629
*	H	US-6,512,529 B1	01-2003	Janssen et al.	715/790
*	I	US-2003/0020763 A1	01-2003	Mayer et al.	345/838
*	J	US-6,542,168 B2	04-2003	Negishi et al.	715/781
*	K	US-6,563,515 B1	05-2003	Reynolds et al.	715/721
*	L	US-6,577,330 B1	06-2003	Tsuda et al.	715/782
*	M	US-6,573,915 B1	06-2003	Sivan et al.	715/781

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

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	X	

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,734,881 B1	05-2004	Will, Craig Alexander	715/811
*	B	US-6,806,888 B2	10-2004	Bhogal et al.	345/660
*	C	US-2004/0221230 A1	11-2004	Kakemura, Atsushi	715/526
*	D	US-6,836,870 B2	12-2004	Abrams, Stephen Alfred	715/730
*	E	US-6,831,666 B1	12-2004	Kreis, Alexander T.	715/781
*	F	US-6,840,627 B2	01-2005	Olbrich, Craig A	353/42
*	G	US-2005/0183020 A1	08-2005	Gnanamgari et al.	715/735
*	H	US-7,006,055 B2	02-2006	Sukthankar et al.	345/1.2
*	I	US-7,028,265 B2	04-2006	Kuromusha et al.	715/788
*	J	US-7,079,153 B2	07-2006	Derry et al.	345/594
*	K	US-7,131,068 B2	10-2006	O'Neal et al.	715/730
*	L	US-7,134,079 B2	11-2006	Brown et al.	715/730
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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	T					

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